# SN74LVT125 3.3-V ABT QUADRUPLE BUS BUFFER WITH 3-STATE OUTPUTS

SCBS133F - MAY 1992 - REVISED OCTOBER 2003

- Supports Mixed-Mode Signal Operation (5-V Input and Output Voltages With 3.3-V V<sub>CC</sub>)
- Supports Unregulated Battery Operation Down to 2.7 V
- Typical V<sub>OLP</sub> (Output Ground Bounce)
  <0.8 V at V<sub>CC</sub> = 3.3 V, T<sub>A</sub> = 25°C
- I<sub>off</sub> Supports Partial-Power-Down Mode Operation
- Bus-Hold Data Inputs Eliminate the Need for External Pullup Resistors
- Latch-Up Performance Exceeds 500 mA Per JEDEC Standard JESD-17
- ESD Protection Exceeds JESD 22
  - 2000-V Human-Body Model (A114-A)
  - 200-V Machine Model (A115-A)

### description/ordering information

This bus buffer is designed specifically for low-voltage (3.3-V)  $V_{CC}$  operation, but with the capability to provide a TTL interface to a 5-V system environment.

The SN74LVT125 features independent line drivers with 3-state outputs. Each output is in the high-impedance state when the associated output-enable ( $\overline{OE}$ ) input is high.

Active bus-hold circuitry holds unused or undriven inputs at a valid logic state. Use of pullup or pulldown resistors with the bus-hold circuitry is not recommended.

This device is fully specified for partial-power-down applications using I<sub>off</sub>. The I<sub>off</sub> circuitry disables the outputs, preventing damaging current backflow through the device when it is powered down.

To ensure the high-impedance state during power up or power down,  $\overline{OE}$  should be tied to V<sub>CC</sub> through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

ТА	PACKAGE <sup>†</sup>		ORDERABLE PART NUMBER	TOP-SIDE MARKING
		Tube	SN74LVT125D	1)/7405
	SOIC – D	Tape and reel	SN74LVT125DR	LVT125
–40°C to 85°C	SOP – NS	Tape and reel	SN74LVT125NSR	LVT125
-40°C 10 85°C	SSOP – DB	Tape and reel	SN74LVT125DBR	LX125
		Tube	SN74LVT125PW	1 1 1 2 5
	TSSOP – PW	Tape and reel	SN74LVT125PWR	LX125

### **ORDERING INFORMATION**

<sup>†</sup> Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.

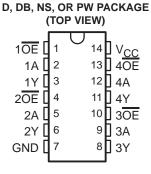


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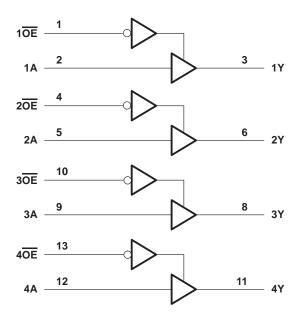


# SN74LVT125 3.3-V ABT QUADRUPLE BUS BUFFER WITH 3-STATE OUTPUTS

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FUNCTION TABLE (each buffer)						
INP	UTS	OUTPUT				
OE	Α	Y				
L	Н	Н				
L	L	L				
Н	Х	Z				

# logic diagram (positive logic)



### absolute maximum ratings over operating free-air temperature range (unless otherwise noted)<sup>†</sup>

Supply voltage range, V <sub>CC</sub> –0.5 V to 4.6 V Input voltage range, V <sub>I</sub> (see Note 1)–0.5 V to 7 V
Voltage range applied to any output in the high state or power-off state, $V_O$ (see Note 1)0.5 V to 7 V Current into any output in the low state, $I_O$
Current into any output in the high state, I <sub>O</sub> (see Note 2)
Input clamp current, I <sub>IK</sub> (V <sub>I</sub> < 0)
Output clamp current, I <sub>OK</sub> (V <sub>O</sub> < 0)
Package thermal impedance, θ <sub>JA</sub> (see Note 3): D package
DB package
NS package
PW package 113°C/W
Storage temperature range, T <sub>stg</sub>

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

- 2. This current flows only when the output is in the high state and  $V_O > V_{CC}$ .
- 3. The package thermal impedance is calculated in accordance with JESD 51-7.



# **SN74LVT125 3.3-V ABT QUADRUPLE BUS BUFFER** WITH 3-STATE OUTPUTS SCBS133F - MAY 1992 - REVISED OCTOBER 2003

## recommended operating conditions (see Note 4)

			MIN	MAX	UNIT
VCC	Supply voltage		2.7	3.6	V
$V_{\text{IH}}$	High-level input voltage		2		V
$V_{IL}$	Low-level input voltage			0.8	V
VI	Input voltage			5.5	V
IOH	High-level output current			-32	mA
IOL	Low-level output current			64	mA
$\Delta t/\Delta v$	Input transition rise or fall rate	Outputs enabled		10	ns/V
Т <sub>А</sub>	Operating free-air temperature		-40	85	°C

NOTE 4: All unused inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.

#### electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		MIN	түр†	MAX	UNIT		
VIK	V <sub>CC</sub> = 2.7 V,	lj = –18 mA			-1.2	V	
	$V_{CC} = MIN \text{ to } MAX^{\ddagger},$	I <sub>OH</sub> = -100 μA		V <sub>CC</sub> -0.2			
VOH	V <sub>CC</sub> = 2.7 V,	I <sub>OH</sub> = -8 mA		2.4			V
	$V_{CC} = 3 V$	I <sub>OH</sub> = -32 mA		2			
		I <sub>OL</sub> = 100 μA				0.2	
	V <sub>CC</sub> = 2.7 V	I <sub>OL</sub> = 24 mA				0.5	
VOL		I <sub>OL</sub> = 16 mA				0.4	V
	V <sub>CC</sub> = 3 V	I <sub>OL</sub> = 32 mA				0.5	
		I <sub>OL</sub> = 64 mA				0.55	
	$V_{CC} = 0 \text{ or MAX}^{\ddagger},$					10	
	V <sub>CC</sub> = 3.6 V	$V_{I} = V_{CC}$ or GND	Control inputs			±1	μA
lj		$V_{I} = V_{CC}$				1	
		$V_{I} = 0$	Data inputs			-5	
loff	$V_{CC} = 0,$	$V_{I}$ or $V_{O}$ = 0 to 4.5 V	$V_{I} \text{ or } V_{O} = 0 \text{ to } 4.5 \text{ V}$				μA
		V <sub>I</sub> = 0.8 V	Deta incuta	75			•
l(hold)	V <sub>CC</sub> = 3 V	V <sub>I</sub> = 2 V	Data inputs	-75			μA
IOZH	V <sub>CC</sub> = 3.6 V,	$V_{O} = 3 V$				5	μΑ
IOZL	V <sub>CC</sub> = 3.6 V,	$V_{O} = 0.5 V$				-5	μΑ
			Outputs high	0.12		0.19	
ICC	$V_{CC} = 3.6 V,$ VI = V_CC or GND	$I_{O} = 0,$	Outputs low			7	mA
			Outputs disabled		0.12	0.19	
∆ICC§	V <sub>CC</sub> = 3 V to 3.6 V,	One input at V <sub>CC</sub> – 0.6 V,	Other inputs at $V_{\mbox{CC}}$ or GND			0.2	mA
Ci	V <sub>I</sub> = 3 V or 0						pF
Co	V <sub>O</sub> = 3 V or 0	•					pF

<sup>†</sup> All typical values are at V<sub>CC</sub> = 3.3 V, T<sub>A</sub> = 25°C.

<sup>‡</sup> For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions. <sup>§</sup> This is the increase in supply current for each input that is at the specified TTL voltage level, rather than V<sub>CC</sub> or GND.



# **SN74LVT125 3.3-V ABT QUADRUPLE BUS BUFFER** WITH 3-STATE OUTPUTS SCBS133F - MAY 1992 - REVISED OCTOBER 2003

# switching characteristics over recommended operating free-air temperature range, $C_L = 50 \text{ pF}$ (unless otherwise noted) (see Figure 1)

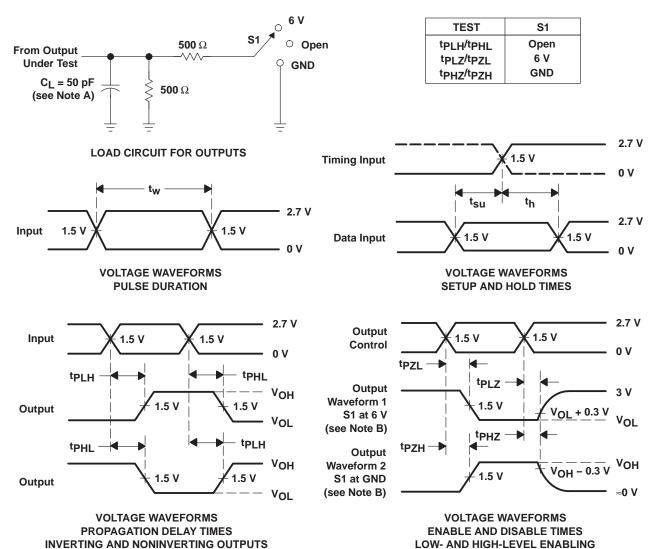
PARAMETER	FROM	TO	V	CC = 3.3 ± 0.3 V	V	V <sub>CC</sub> =	UNIT	
	(INPUT)	(OUTPUT)	MIN	TYP†	MAX	MIN	MAX	
<sup>t</sup> PLH	٨	V	1	2.7	4		4.5	20
<sup>t</sup> PHL	A	Ť	1	2.9	3.9		4.9	ns
<sup>t</sup> PZH	OE	V	1	3.4	4.7		6	2
<sup>t</sup> PZL	OE	Ŷ	1.1	3.4	4.7		6.5	ns
<sup>t</sup> PHZ	OE	V	1.8	3.7	5.1		5.7	20
<sup>t</sup> PLZ	UE	UE T		2.6	4.5		4	ns

<sup>†</sup> All typical values are at V<sub>CC</sub> = 3.3 V, T<sub>A</sub> =  $25^{\circ}$ C.



## SN74LVT125 3.3-V ABT QUADRUPLE BUS BUFFER WITH 3-STATE OUTPUTS

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### PARAMETER MEASUREMENT INFORMATION

NOTES: A. CL includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz, Z<sub>O</sub> = 50  $\Omega$ , t<sub>r</sub>  $\leq$  2.5 ns, t<sub>f</sub>  $\leq$  2.5 ns.
- D. The outputs are measured one at a time with one transition per measurement.
- E. All parameters and waveforms are not applicable to all devices.

#### Figure 1. Load Circuit and Voltage Waveforms





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### **PACKAGING INFORMATION**

Orderable Device	Status <sup>(1)</sup>	Package Type	Package Drawing	Pins	Package Qty	Eco Plan <sup>(2)</sup>	Lead/ Ball Finish	MSL Peak Temp <sup>(3)</sup>	Samples (Requires Login)
SN74LVT125D	NRND	SOIC	D	14	50	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	Samples Not Available
SN74LVT125DBLE	OBSOLETE	SSOP	DB	14		TBD	Call TI	Call TI	Replaced by SN74LVT125DBR
SN74LVT125DBR	NRND	SSOP	DB	14	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	Samples Not Available
SN74LVT125DBRG4	NRND	SSOP	DB	14	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	Samples Not Available
SN74LVT125DG4	NRND	SOIC	D	14	50	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	Samples Not Available
SN74LVT125DR	ACTIVE	SOIC	D	14	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	Purchase Samples
SN74LVT125DRG4	ACTIVE	SOIC	D	14	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	Purchase Samples
SN74LVT125NSR	NRND	SO	NS	14	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	Samples Not Available
SN74LVT125PW	NRND	TSSOP	PW	14	90	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	Samples Not Available
SN74LVT125PWG4	NRND	TSSOP	PW	14	90	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	Samples Not Available
SN74LVT125PWLE	OBSOLETE	TSSOP	PW	14		TBD	Call TI	Call TI	Replaced by SN74LVT125PWR
SN74LVT125PWR	ACTIVE	TSSOP	PW	14	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	Purchase Samples
SN74LVT125PWRG4	ACTIVE	TSSOP	PW	14	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	Purchase Samples

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

# PACKAGE OPTION ADDENDUM



31-Jul-2010

<sup>(2)</sup> Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

**TBD:** The Pb-Free/Green conversion plan has not been defined.

**Pb-Free (RoHS):** TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

**Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

<sup>(3)</sup> MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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#### OTHER QUALIFIED VERSIONS OF SN74LVT125 :

• Automotive: SN74LVT125-Q1

Enhanced Product: SN74LVT125-EP

NOTE: Qualified Version Definitions:

- Automotive Q100 devices qualified for high-reliability automotive applications targeting zero defects
- Enhanced Product Supports Defense, Aerospace and Medical Applications

# PACKAGE MATERIALS INFORMATION

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### TAPE AND REEL INFORMATION

#### REEL DIMENSIONS

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TAPE AND REEL INFORMATION

#### TAPE DIMENSIONS



A0	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

*All dimensions are nominal												
Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74LVT125DBR	SSOP	DB	14	2000	330.0	16.4	8.2	6.6	2.5	12.0	16.0	Q1
SN74LVT125DR	SOIC	D	14	2500	330.0	16.4	6.5	9.0	2.1	8.0	16.0	Q1
SN74LVT125DR	SOIC	D	14	2500	330.0	16.4	6.5	9.0	2.1	8.0	16.0	Q1
SN74LVT125NSR	SO	NS	14	2000	330.0	16.4	8.2	10.5	2.5	12.0	16.0	Q1
SN74LVT125PWR	TSSOP	PW	14	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1

TEXAS INSTRUMENTS

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# PACKAGE MATERIALS INFORMATION

14-Jul-2012



\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN74LVT125DBR	SSOP	DB	14	2000	367.0	367.0	38.0
SN74LVT125DR	SOIC	D	14	2500	333.2	345.9	28.6
SN74LVT125DR	SOIC	D	14	2500	367.0	367.0	38.0
SN74LVT125NSR	SO	NS	14	2000	367.0	367.0	38.0
SN74LVT125PWR	TSSOP	PW	14	2000	367.0	367.0	35.0

D (R-PDSO-G14)

PLASTIC SMALL OUTLINE



NOTES: A. All linear dimensions are in inches (millimeters).

- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
- E. Reference JEDEC MS-012 variation AB.





NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
  E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



PW (R-PDSO-G14)

PLASTIC SMALL OUTLINE



A. An integration of the information o

Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0,15 each side.

Body width does not include interlead flash. Interlead flash shall not exceed 0,25 each side.

E. Falls within JEDEC MO-153





NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



# MECHANICAL DATA

### PLASTIC SMALL-OUTLINE PACKAGE

#### 0,51 0,35 ⊕0,25⊛ 1,27 8 14 0,15 NOM 5,60 8,20 5,00 7,40 $\bigcirc$ Gage Plane ₽ 0,25 7 1 1,05 0,55 0°-10° Δ 0,15 0,05 Seating Plane — 2,00 MAX 0,10PINS \*\* 14 16 20 24 DIM 10,50 10,50 12,90 15,30 A MAX A MIN 9,90 9,90 12,30 14,70 4040062/C 03/03

NOTES: A. All linear dimensions are in millimeters.

NS (R-PDSO-G\*\*)

**14-PINS SHOWN** 

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15.



# **MECHANICAL DATA**

MSSO002E - JANUARY 1995 - REVISED DECEMBER 2001

# DB (R-PDSO-G\*\*)

PLASTIC SMALL-OUTLINE

28 PINS SHOWN



NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion not to exceed 0,15.
- D. Falls within JEDEC MO-150



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